# PHK12NQ10T

# N-channel TrenchMOS standard level FET

Rev. 02 — 24 November 2009

**Product data sheet** 

### 1. Product profile

#### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

#### 1.2 Features and benefits

 Low conduction losses due to low on-state resistance

#### 1.3 Applications

DC-to-DC primary side switching

■ Portable equipment

#### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}$	-	-	100	V
I <sub>D</sub>	drain current	$T_{sp} = 25 ^{\circ}\text{C}; V_{GS} = 10 \text{V};$ see Figure 3 and 1	-	-	11.6	А
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> = 25 °C;see <u>Figure 2</u>	-	-	8.9	W
Dynamic	characteristics					
$Q_{GD}$	gate-drain charge	$V_{GS} = 10 \text{ V}; I_D = 12 \text{ A};$ $V_{DS} = 50 \text{ V}; T_j = 25 \text{ °C};$ see Figure 11	-	9	-	nC
Static ch	aracteristics					
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 6 \text{ A};$ $T_j = 25 ^{\circ}\text{C};$ see Figure 9 and 10	-	23.7	28	mΩ



### 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source	8月月月5	D
3	S	source		$G \longrightarrow \overline{A}$
4	G	gate		
5	D	drain	1 1 1 1 14	mbb076 S
6	D	drain	SOT96-1 (SO8)	
7	D	drain		
8	D	drain		

## 3. Ordering information

Table 3. Ordering information

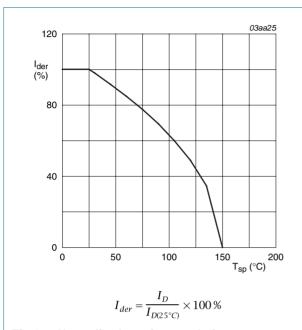
Type number	Package		
	Name	Description	Version
PHK12NQ10T	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1

### 4. Limiting values

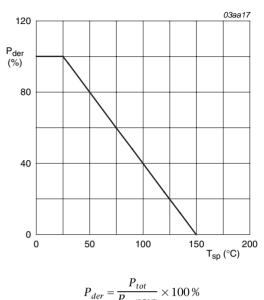
Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 150 °C	-	100	V
$V_{DGR}$	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	100	V
$V_{GS}$	gate-source voltage		-20	20	V
$I_D$	drain current	$T_{sp} = 100  ^{\circ}\text{C};  V_{GS} = 10  \text{V}; \text{see } \frac{\text{Figure 1}}{}$	-	7.4	Α
		$T_{sp}$ = 25 °C; $V_{GS}$ = 10 V;see <u>Figure 3</u> and <u>1</u>	-	11.6	Α
$I_{DM}$	peak drain current	$T_{sp} = 25 \text{ °C}; t_p \le 10 \mu\text{s}; \text{ pulsed;see } \frac{\text{Figure 3}}{}$	-	48	Α
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> = 25 °C;see <u>Figure 2</u>	-	8.9	W
T <sub>stg</sub>	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-dr	ain diode				
Is	source current	$T_{sp} = 25  ^{\circ}\text{C}$	-	12	Α
I <sub>SM</sub>	peak source current	$T_{sp} = 25  ^{\circ}\text{C}; t_p \le 10  \mu\text{s}; \text{ pulsed}$	-	48	Α
Avalanche	ruggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 11.5 A; $V_{sup} \le$ 100 V; unclamped; $t_p$ = 0.1 ms	-	65	mJ

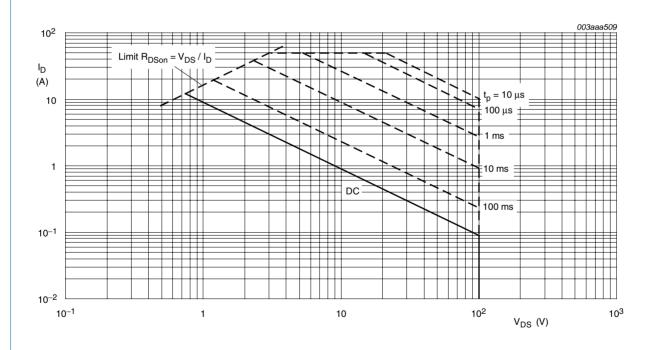


Normalized continuous drain current as a function of solder point temperature



 $P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$ 

Normalized total power dissipation as a Fig 2. function of solder point temperature



Safe operating area; continuous and peak drain currents as a function of drain-source voltage Fig 3.

 $T_{sp} = 25$ °C;  $I_{DM}$  is single pulse;

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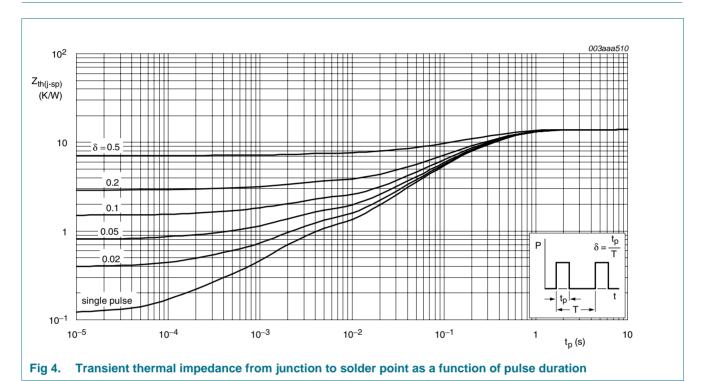
#### N-channel TrenchMOS standard level FET

#### Thermal characteristics 5.

Thermal characteristics Table 5.

**Product data sheet** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	see Figure 4	-	-	15	K/W



### **Characteristics**

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
$V_{(BR)DSS}$	drain-source	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^{\circ}C$	89	-	-	V
	breakdown voltage	$I_D$ = 250 $\mu$ A; $V_{GS}$ = 0 V; $T_j$ = 25 °C	100	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 150$ °C; see Figure 8	1.2	-	-	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see Figure 8	-	-	4.4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see Figure 8	2	3	4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
		$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 ^{\circ}\text{C}$	-	-	100	μΑ
l <sub>GSS</sub>	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nΑ
		$V_{GS}$ = -20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	10	100	nΑ
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 6 \text{ A}; T_j = 150 ^{\circ}\text{C};$ see Figure 9 and 10	-	52.1	61.6	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 6 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 9 and 10	-	23.7	28	mΩ
Dynamic	characteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 12 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$	-	35	-	nC
$Q_{GS}$	gate-source charge	T <sub>j</sub> = 25 °C; see <u>Figure 11</u>	-	7.8	-	nC
$Q_{GD}$	gate-drain charge		-	9	-	nC
C <sub>iss</sub>	input capacitance	$V_{DS} = 25 \text{ V; } V_{GS} = 0 \text{ V; } f = 1 \text{ MHz;}$ $T_j = 25 \text{ °C;see } \frac{\text{Figure } 12}{\text{ Composition}}$	-	1965	-	pF
C <sub>oss</sub>	output capacitance	$V_{DS} = 25 \text{ V; } V_{GS} = 0 \text{ V; } f = 1 \text{ MHz;}$ $T_j = 25 \text{ °C;see } \frac{\text{Figure 11}}{Constant of the constant of $	-	260	-	pF
C <sub>rss</sub>	reverse transfer capacitance	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; \text{see } \frac{\text{Figure } 12}{\text{ Composition}}$	-	90	-	pF
d(on)	turn-on delay time	$V_{DS} = 50 \text{ V}; R_L = 8.3 \Omega; V_{GS} = 10 \text{ V};$	-	23	-	ns
r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C; I_D = 6 A$	-	21	-	ns
d(off)	turn-off delay time		-	52	-	ns
i <sub>f</sub>	fall time		-	11	-	ns
Source-d	rain diode					
V <sub>SD</sub>	source-drain voltage	$I_S = 12 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see Figure 13	-	0.83	1	V
trr	reverse recovery time	$I_S$ = 12 A; $dI_S/dt$ = -100 A/ $\mu$ s; $V_{GS}$ = 0 V; $V_{DS}$ = 25 V; $T_j$ = 25 °C	-	86	-	ns
	recovered charge	$I_S = 12 \text{ A}$ ; $dI_S/dt -100 \text{ A/}\mu s$ ; $V_{GS} = 0 \text{ V}$ ;		120		nC

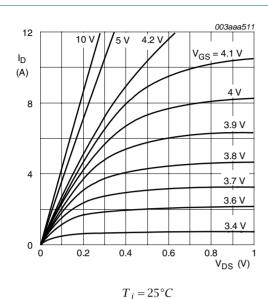
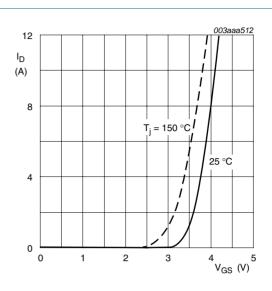


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_j = 25$ °C and 150°C; $V_{DS} > I_D \times R_{DSon}$ 

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values

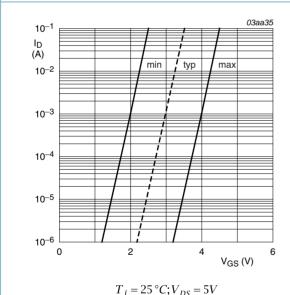
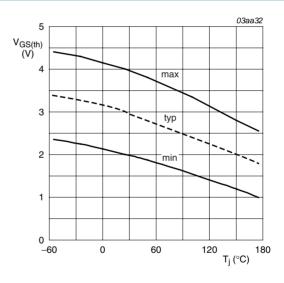


Fig 7. Sub-threshold drain current as a function of gate-source voltage



 $I_D = 1 \, mA; V_{DS} = V_{GS}$ 

Fig 8. Gate-source threshold voltage as a function of junction temperature

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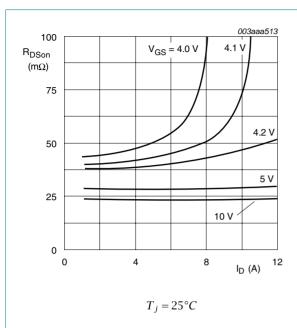


Fig 9. Drain-source on-state resistance as a function of drain current; typical values

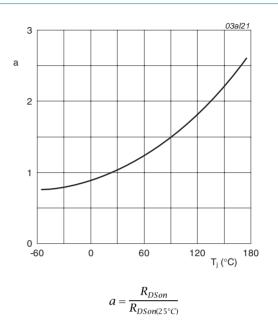


Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature

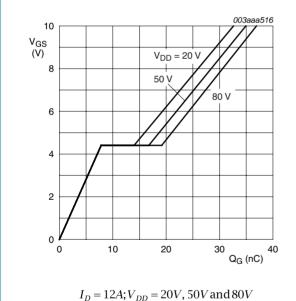


Fig 11. Gate-source voltage as a function of gate charge; typical values

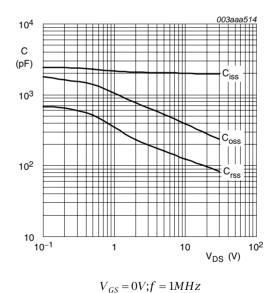
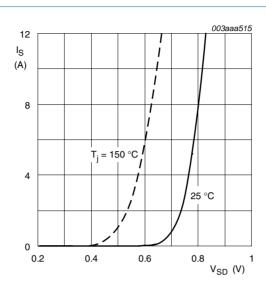


Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



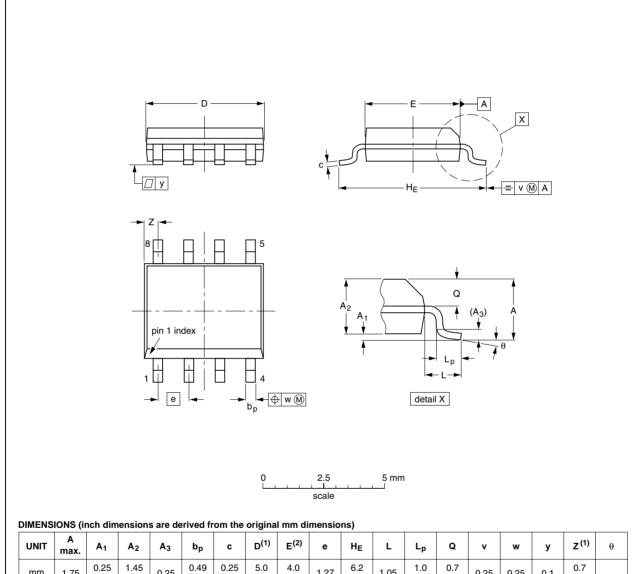
 $T_j = 25 \,^{\circ} C \text{ and } 150 \,^{\circ} C; V_{GS} = 0V$ 

Fig 13. Source current as a function of source-drain voltage; typical values

### Package outline

#### SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(2)</sup>	е	HE	L	Lp	Q	v	w	у	z <sup>(1)</sup>	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.20 0.19	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016		0.01	0.01	0.004	0.028 0.012	0°

- 1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT96-1	076E03	MS-012				<del>99-12-27</del> 03-02-18

Fig 14. Package outline SOT96-1 (SO8)



### 8. Revision history

#### Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
PHK12NQ10T_2	20091124	Product data sheet	-	PHK12NQ10T-01				
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>							
	<ul><li>Legal texts</li></ul>	have been adapted to the	e new company name w	here appropriate.				
PHK12NQ10T-01 (9397 750 11949)	20030915	Product data	-	-				

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#### 9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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## PHK12NQ10T

#### N-channel TrenchMOS standard level FET

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